Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/773,550	NAKANO ET AL.
Examiner	Art Unit
Chongshan Chen	2162

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	SEARCHED				
Class	Subclass	Date	Examiner		
707	6	9/17/2005	cc		

TNI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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(INCLUDING SEARCH	1	,
	DATE	EXMR
PALM	9/17/2005	cc
EAST search (USPAT, US-PGPUB, IBM_TDB)	9/17/2005	cc